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IEC 61850, IEC 61400-25, IEC 60870-5-104, DNP3, IEC 62351 ...lec 60870-6 Tase.2, Iec 62351, Dnp3, Iec 61970 Cim, Iec 61968, Iec 61158, Iec 61499, IEEE 802.3, And ISO 9506 MMS To Name Just A Few. To Keep Abreast Of The Latest Technical De May 2th, 2024Modular Time Relays, Type TR IEC 61812-1, IEC 61000-6-2 ...Ł Designed In Accordance With IEC 61812-1, IEC 61000-6-2 & EN 50178. Ł Time Adjustment From 50 Milliseconds Up To 100 Hours. Ł Outgoing Change-over Contact Rated 8 Amps / 250 V. Ł Flexible Voltage Supply & Control Input Ł 12 V - 240 Vac/dc For TRL07 & TRLPG Ł 24 Feb 6th, 2024IEC AC Option IEC 61000-4 AC Immunity Test RoutinesCommon Features For All IEC 61000-4 Test Sequences • Pre-set Test Sequences And Test Levels Conform To IEC 61000-4 Test Standards, Ready To Test Out Of The Box. No Need For Any Programming By The End-user Saves Time. • Immunity Tests Can Be Run Continuously Or In Single . Jun 4th, 2024.

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